

GA10SICP12-247

Silicon Carbide Junction Transistor/Schottky Diode Co-pack

 V_{DS} = 1200 V $R_{DS(ON)}$ = 120 m Ω $I_{D (Tc = 25^{\circ}C)}$ = 25 A $h_{FE (Tc = 25^{\circ}C)}$ 100

Features

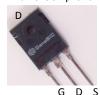
- 175°C Maximum Operating Temperature
- · Gate Oxide free SiC switch
- Exceptional Safe Operating Area
- Integrated SiC Schottky Rectifier
- Excellent Gain Linearity
- Temperature Independent Switching Performance
- Low output capacitance
- Positive temperature co-efficient of R_{DS,ON}
- Suitable for connecting an anti-parallel diode

Advantages

- Compatible with Si MOSFET/IGBT Gate Drive ICs
- > 20 µs Short-Circuit Withstand Capability
- Lowest-in-class Conduction Losses
- High Circuit Efficiency
- Minimal Input Signal distortion
- · High Amplifier Bandwidth
- Reduced cooling requirements
- Reduced system size

Package

• RoHS Compliant





TO-247AB

Applications

- Down Hole Oil Drilling, Geothermal Instrumentation
- Hybrid Electric Vehicles (HEV)
- Solar Inverters
- Switched-Mode Power Supply (SMPS)
- Power Factor Correction (PFC)
- Induction Heating
- Uninterruptible Power Supply (UPS)
- Motor Drives

Maximum Ratings at T_i = 175 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values	Unit
SiC Junction Transistor				
Drain – Source Voltage	V_{DS}	V _{GS} = 0 V	1200	V
Continuous Drain Current	I _D	T _{C,MAX} = 95 °C	10	Α
Gate Peak Current	I _{GM}		10	Α
Turn-Off Safe Operating Area	RBSOA	T_{VJ} = 175 °C, I_{G} = 1 A, Clamped Inductive Load	$I_{D,max} = 10$	Α
Short Circuit Safe Operating Area	SCSOA	T_{VJ} = 175 °C, I_G = 1 A, V_{DS} = 800 V, Non Repetitive	20	μs
Reverse Gate – Source Voltage	V_{SG}		30	V
Reverse Drain – Source Voltage	V_{SD}		25	V
Power Dissipation	P_{tot}	$T_C = 95 ^{\circ}C$	91	W
Storage Temperature	T_{stg}		-55 to 175	°C
Free-wheeling Silicon Carbide diode				
DC-Forward Current	I _F	T _C ≤ 150 °C	10	Α
Non Repetitive Peak Forward Current	I _{FM}	$T_C = 25 ^{\circ}\text{C}, t_P = 10 \mu\text{s}$	280	Α
Surge Non Repetitive Forward Current	$I_{F,SM}$	t_P = 10 ms, half sine, T_C = 25 °C	65	Α
Thermal Characteristics				
Thermal resistance, junction - case	R _{thJC}	SiC Junction Transistor	0.88	°C/W
Thermal resistance, junction - case	R_{thJC}	SiC Diode	0.85	°C/W
Mechanical Properties				
Mounting torque	М		0.6	Nm

GA10SICP12-247



Electrical Characteristics at T_i = 175 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values		Unit	
rai ailletei	Syllibol	Conditions	min.	typ. max.		Ullit
SJT On-State Characteristics						
		I _D = 10 A, I _G = 200 mA, T _i = 25 °C		120		
Drain – Source On Resistance	$R_{DS(ON)}$	$I_D = 10 \text{ A}, I_G = 400 \text{ mA}, T_i = 125 °C$		150		mΩ
	(,	$I_D = 10 \text{ A}, I_G = 800 \text{ mA}, T_i = 175 °C$		220		
Cata Farmard Valtage		I _G = 500 mA, T _i = 25 °C		3.3		
Gate Forward Voltage	$V_{GS(FWD)}$	$I_G = 500 \text{ mA}, T_j = 175 ^{\circ}\text{C}$		3.1		V
DC Current Gain	h _{FE}	V _{DS} = 5 V, I _D = 10 A, T _j = 25 °C		100		
20 04.7.5.11, 04.11.		$V_{DS} = 5 \text{ V}, I_{D} = 10 \text{ A}, T_{j} = 175 \text{ °C}$		TBD	<u> </u>	
SJT Off-State Characteristics						
		$V_R = 1200 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 25 \text{ °C}$		350		
Drain Leakage Current	I _{DSS}	$V_R = 1200 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 125 ^{\circ}\text{C}$		530		nA
		$V_R = 1200 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 175 ^{\circ}\text{C}$		700		
Gate Leakage Current	I _{SG}	$V_{SG} = 20 \text{ V}, T_j = 25 ^{\circ}\text{C}$		20		nA
SJT Capacitance Characteristics						
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V}, V_{D} = 1 \text{ V}, f = 1 \text{ MHz}$		tbd		pF
Reverse Transfer/Output Capacitance	C_{rss}/C_{oss}	$V_D = 1 V, f = 1 MHz$		tbd		pF
SJT Switching Characteristics						
Turn On Delay Time	f			tbd		ns
Rise Time	t _{d(on)}	V _{DD} = 800 V, I _D = 10 A,		tbd		
Turn Off Delay Time	t_	$R_{G(on)} = R_{G(off)} = \text{tbd } \Omega,$		tbd		ns ns
Fall Time	$t_{d(off)}$	FWD = GB10SLT12,		tbd		
	E _{on}	T _j = 25 °C Refer to Figure 15 for gate current		tbd		ns
Turn-On Energy Per Pulse Turn-Off Energy Per Pulse				tbd		μJ μJ
•	E _{off}	waveform		tbd		
Total Switching Energy Turn On Delay Time				tbd		μJ
Rise Time	$\frac{t_{d(on)}}{t_r}$	V _{DD} = 800 V, I _D = 10 A,		tbd		
Turn Off Delay Time		$R_{G(on)} = R_{G(off)} = \text{tbd } \Omega,$		tbd		ns
Fall Time	$t_{d(off)}$	FWD = GB10SLT12,		tbd		ns
Turn-On Energy Per Pulse		T _j = 175 °C		tbd		ns
Turn-Off Energy Per Pulse Turn-Off Energy Per Pulse	E _{on}	Refer to Figure 15 for gate current				μJ
Turn-On Energy Fer Fulse Total Switching Energy	E _{off}	waveform		tbd tbd		μJ μJ
3,				tbu		μυ
Free-wheeling Silicon Carbide Schott	ky Diode	I _F = 10 A, V _{GF} = 0 V,		<u> </u>	1	
Forward Voltage	V_{F}	$T_{\rm F} = 10 \text{A}, V_{\rm GE} = 0 \text{V},$ $T_{\rm j} = 25 ^{\circ}\text{C} (175 ^{\circ}\text{C})$		1.55		V
Diode Knee Voltage	$V_{D(knee)}$	T _j = 25 °C, I _F = 1 mA		0.8		V
Peak Reverse Recovery Current	I _{rrm}	I _F = 10 A, V _{GE} = 0 V, V _R = 800 V,		tbd		Α
Reverse Recovery Time	t _{rr}	-dI _F /dt = 625 A/μs, T _j = 175 °C		tbd		ns
Rise Time	t _r	V 200 V 1 10 1		tbd		ns
Fall Time	t_f	V_{DD} = 800 V, I_{D} = 10 A, R_{gon} = R_{goff} = tbd Ω ,		tbd		ns
Turn-On Energy Loss Per Pulse	Eon	$R_{gon} = R_{goff} = tod \Omega,$ $T_i = 25 {}^{\circ}C$		tbd		μJ
Turn-Off Energy Loss Per Pulse	E _{off}			tbd		μJ
Reverse Recovery Charge	Q_{rr}			tbd		nC
Rise Time	t _r	_		tbd		ns
Fall Time	t _f	V_{DD} = 800 V, I_{D} = 10 A, R_{gon} = R_{goff} = tbd Ω , T_{j} = 175 °C		tbd		ns
Turn-On Energy Loss Per Pulse	E _{on}			tbd		μJ
Turn-Off Energy Loss Per Pulse	E _{off}			tbd		μJ
Reverse Recovery Charge	Q_{rr}			tbd		nC

Figures

TBD

TBD

Figure 1: Typical Output Characteristics at 25 °C

Figure 2: Typical Output Characteristics at 125 °C

TBD

TBD

Figure 3: Typical Output Characteristics at 175 °C

Figure 4: Typical Gate Source I-V Characteristics vs. Temperature

TBD

TBD

Figure 5: Normalized On-Resistance and Current Gain vs. Temperature

Figure 6: Typical Blocking Characteristics



TBD

TBD

Figure 7: Capacitance Characteristics

Figure 8: Capacitance Characteristics

TBD

TBD

Figure 9: Typical Hard-switched Turn On Waveforms

Figure 10: Typical Hard-switched Turn Off Waveforms

TBD

TBD

Figure 11: Typical Turn On Energy Losses and Switching Times vs. Temperature

Figure 12: Typical Turn Off Energy Losses and Switching Times vs. Temperature



TBD

TBD

Figure 13: Typical Turn On Energy Losses vs. Drain Current

Figure 14: Typical Turn Off Energy Losses vs. Drain Current

TBD

TBD

Figure 15: Typical Gate Current Waveform

Figure 16: Typical Hard Switched Device Power Loss vs. Switching Frequency ¹

TBD

TBD

¹ – Representative values based on device switching energy loss. Actual losses will depend on gate drive conditions, device load, and circuit topology.



TBD

TBD

Figure 19: Turn-Off Safe Operating Area

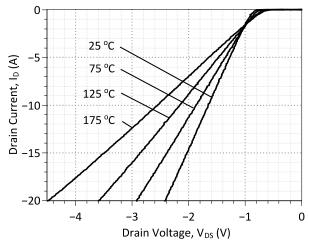


Figure 21: Typical FWD Forward Characteristics

Figure 20: Transient Thermal Impedance



Gate Drive Theory of Operation for the GA10SICP12-263

The SJT transistor is a current controlled transistor which requires a positive gate current for turn-on as well as to remain in on-state. An ideal gate current waveform for ultra-fast switching of the SJT, while maintaining low gate drive losses, is shown in Figure 22.

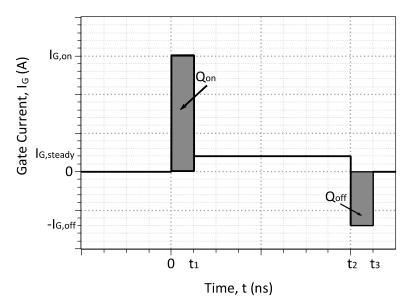


Figure 22: Idealized Gate Current Waveform

Gate Currents, I_{G.ok}/-I_{G.ok} and Voltages during Turn-On and Turn-Off

An SJT is rapidly switched from its blocking state to on-state, when the necessary gate charge, Q_G , for turn-on is supplied by a burst of high gate current, $I_{G,on}$, until the gate-source capacitance, C_{GS} , and gate-drain capacitance, C_{GD} , are fully charged.

$$I_{G,on} * t_1 \ge Q_{gs} + Q_{gd}$$

The $I_{G,pon}$ pulse should ideally terminate, when the drain voltage falls to its on-state value, in order to avoid unnecessary drive losses during the steady on-state. In practice, the rise time of the $I_{G,on}$ pulse is affected by the parasitic inductances, L_{par} in the module and drive circuit. A voltage developed across the parasitic inductance in the source path, L_s , can de-bias the gate-source junction, when high drain currents begin to flow through the device. The applied gate voltage should be maintained high enough, above the $V_{GS,ON}$ level to counter these effects.

A high negative peak current, $-I_{G,off}$ is recommended at the start of the turn-off transition, in order to rapidly sweep out the injected carriers from the gate, and achieve rapid turn-off. While satisfactory turn off can be achieved with $V_{GS} = 0$ V, a negative gate voltage V_{GS} may be used in order to speed up the turn-off transition.

Steady On-State

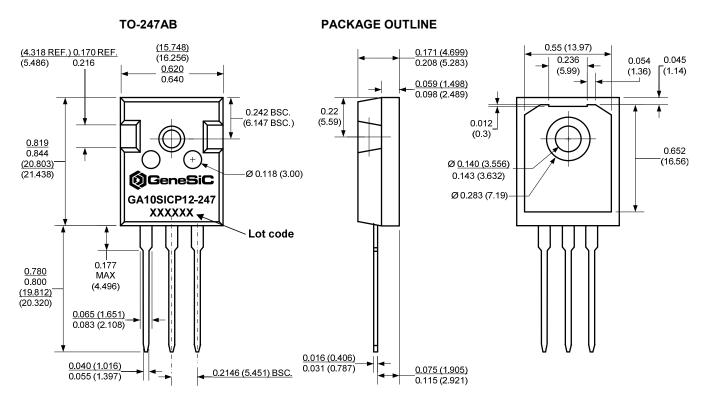
After the device is turned on, I_G may be advantageously lowered to $I_{G,steady}$ for reducing unnecessary gate drive losses. The $I_{G,steady}$ is determined by noting the DC current gain, h_{FE} , of the device

The desired $I_{G,steady}$ is determined by the peak device junction temperature T_J during operation, drain current I_D , DC current gain h_{FE} , and a 50 % safety margin to ensure operating the device in the saturation region with low on-state voltage drop by the equation:

$$I_{G,steady} \approx \frac{I_D}{h_{FF}(T, I_D)} * 1.5$$



Package Dimensions:



NOTE

- 1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
 2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

Revision History						
Date	Revision	Comments	Supersedes			
2014/08/25	1	Gate Drive Theory Update				
2013/09/12	0	Initial release				

Published by GeneSiC Semiconductor, Inc. 43670 Trade Center Place Suite 155 Dulles, VA 20166

GeneSiC Semiconductor, Inc. reserves right to make changes to the product specifications and data in this document without notice.

GeneSiC disclaims all and any warranty and liability arising out of use or application of any product. No license, express or implied to any intellectual property rights is granted by this document.

Unless otherwise expressly indicated, GeneSiC products are not designed, tested or authorized for use in life-saving, medical, aircraft navigation, communication, air traffic control and weapons systems, nor in applications where their failure may result in death, personal injury and/or property damage.



SPICE Model Parameters

This is a secure document. Please copy this code from the SPICE model PDF file on our website (http://www.genesicsemi.com/images/products-sic/igbt-copack/GA10SICP12-247-spice.pdf) into LTSPICE (version 4) software for simulation of the GA10SICP12-247.

```
MODEL OF GeneSiC Semiconductor Inc.
                                 $
     $Revision: 1.1
     $Date: 23-JUN-2014
                                 Ś
     GeneSiC Semiconductor Inc.
     43670 Trade Center Place Ste. 155
     Dulles, VA 20166
     http://www.genesicsemi.com/index.php/sic-products/copack
     COPYRIGHT (C) 2014 GeneSiC Semiconductor Inc.
     ALL RIGHTS RESERVED
* These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY
* OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED
* TO ANY IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A
* PARTICULAR PURPOSE."
* Models accurate up to 2 times rated drain current.
 Start of GA10SICP12-247 SPICE Model
.SUBCKT GA10SIPC12 DRAIN GATE SOURCE
Q1 DRAIN GATE SOURCE GA10SIPC12 Q
D1 SOURCE DRAIN GA10SIPC12 D1
D2 SOURCE DRAIN GA10SIPC12 D2
.model GA10SIPC12 Q NPN
+ IS
          5.00E-47
                           ISE
                                      1.26E-28
                                                       ΕG
                                                                  3.23
          100
                                      0.55
+ BF
                                                                  350
                           BR
                                                       IKF
                           ΝE
                                      2
+ NF
           1
                                                       RB
                                                                  6.97
          0.01
+ RE
                           RC
                                      0.1
                                                       CJC
                                                                  3.5E-10
+ VJC
           3
                           MJC
                                      0.5
                                                       CJE
                                                                  1.11E-09
           3
                                                                  3
+ VJE
                           MJE
                                      0.5
                                                       XTI
+ XTB
          -1.2
                           TRC1
                                      7.00E-03
                                                             GeneSiC Semi
                                                       MFG
.MODEL GA10SIPC12 D1 D
       4.55E-15
                                      0.0736
+ IS
                           RS
                                                       N
                                                                  1
+ IKF
          1000
                           EG
                                      1.2
                                                       XTI
                                                                  -2
+ TRS1
          0.005434
                           TRS2
                                      2.71739E-05
                                                                  6.40E-10
                                                       CJO
+ VJ
           0.469
                                      1.508
                                                       FC
                                                                  0.5
+ TT
           1.00E-10
.MODEL GA10SIPC12 D2 D
       1.54E-22
+ IS
                           RS
                                      0.19
                                                 TRS1
                                                             -0.004
+ N
           3.941
                           ΕG
                                      3.23
                                                  IKF
                                                             19
                                      0.5
+ XTI
           0
                           FC
                                                 TT
                                                             0
.ENDS
```

* End of GA10SICP12-247 SPICE Model